

Signal Detection in Noise

In this section, we are interested in the various *structures* that arise from different assumptions on a single problem. We have vector observations that we will manipulate.

$$\begin{aligned} H_0 : \underline{Y} &= \underline{N} + \underline{S}_0 \\ H_1 : \underline{Y} &= \underline{N} + \underline{S}_1 \end{aligned}$$

in the general case where $p_N(\underline{n})$ is the noise density, we form

$$\begin{aligned} L(\underline{y}) &= \frac{p_1(\underline{y})}{p_0(\underline{y})} \\ \text{where } p_i(\underline{y}) &= \mathbf{E}_S \{p_N(\underline{y} - \underline{s})\} \end{aligned}$$

Consider the following cases:

1. Detection of Known/Deterministic Signals in IID Noise

$$\begin{aligned} H_0 : \underline{Y} &= \underline{N} \\ H_1 : \underline{Y} &= \underline{N} + \underline{s} \end{aligned}$$

We form the likelihood ratio,

$$\begin{aligned} L(\underline{y}) &= \prod_{k=1}^n L_k(y_k) \\ L_k(y_k) &= \frac{p_{N_k}(y_k - s_{1,k})}{p_{N_k}(y_k - s_{0,k})} \end{aligned}$$

Our rule is then,

$$\delta(\underline{y}) = \begin{cases} 1 & > \\ \gamma \sum_{k=1}^n \log L_k(y_k) & = \log \tau \\ 0 & < \end{cases}$$

with most IID noise, detector has a **correlator-type** structure.

2. Locally Optimum Detection of Coherent Signals in IID Noise

$$\begin{aligned} H_0 : \underline{Y} &= \underline{N} \\ H_1 : \underline{Y} &= \underline{N} + \theta \underline{s} \\ \theta &> 0 \text{ unknown constant} \end{aligned}$$

$$\begin{aligned} L_\theta(\underline{y}) &= \prod_{k=1}^n \frac{p_{N_k}(y_k - \theta s_k)}{p_{N_k}(y_k)} \\ \left. \frac{\partial}{\partial \theta} L_\theta(\underline{y}) \right|_{\theta=0} &= \sum_{k=1}^n s_k g_{lo}(y_k) \\ \text{where } g_{lo}(x) &= -\frac{\frac{d}{dx} p_{N_k}(x)}{p_{N_k}(x)} \text{ locally optimal non-linearity} \end{aligned}$$

The result is a **non-linear correlator**.

3. Detection of Deterministic Signals in IID Gaussian Noise

Recall that if $\underline{N} \sim \mathcal{N}(\underline{\mu}, \Sigma)$

$$p_N(\underline{n}) = \frac{1}{(2\pi)^{\frac{n}{2}} |\Sigma|^{\frac{1}{2}}} \exp \left\{ -\frac{1}{2} (\underline{n} - \underline{\mu})^T \Sigma^{-1} (\underline{n} - \underline{\mu}) \right\}$$

Assuming that $\Sigma > 0$, we compute the likelihood ratio, take the logarithm and absorb constants into the threshold, the resulting rule is

$$\delta(\underline{y}) = \begin{cases} 1 & \text{if } T(\underline{y}) = \sum_{k=1}^n \tilde{s}_k y_k \geq \tau' \\ 0 & < \end{cases}$$

$$\begin{aligned} \text{where } \tilde{\underline{s}} &= \Sigma^{-1}(\underline{s}_1 - \underline{s}_0) \\ \text{given } H_i \quad T(\underline{y}) &\sim \mathcal{N}(\tilde{\underline{s}}^T \underline{s}_i, (\underline{s}_1 - \underline{s}_0)^T \Sigma^{-1} (\underline{s}_1 - \underline{s}_0)) \end{aligned}$$

Analysis reduces to that for scalar location testing with Gaussian error. Performance goes with $d^2 = (\underline{s}_1 - \underline{s}_0)^T \Sigma^{-1} (\underline{s}_1 - \underline{s}_0)$.

4. Reduction of Dependent Gaussian Noise Case to IID Gaussian Noise Case

Recall the spectral decomposition of a matrix

$$\begin{aligned} \Sigma &= \sum_{k=1}^n \lambda_k \underline{v}_k \underline{v}_k^T = V \Lambda V^T \\ \lambda_k &= \text{eigenvalue with } \Lambda = \text{diag}[\lambda_1, \dots, \lambda_n] \\ \underline{v}_k &= \text{eigenvector with } V = [\underline{v}_1, \dots, \underline{v}_n] \end{aligned}$$

consider two decompositions of Σ

$$\begin{aligned} \Sigma &= B^2 \text{ where } B = V \Lambda^{\frac{1}{2}} V^T \\ \Sigma &= C C^T \text{ where } C = \text{Cholesky decomposition} \\ \text{form } \hat{\underline{Y}} &= B^{-1} \underline{Y} \quad \text{note } B^{-1} \underline{N} \sim \mathcal{N}(\underline{0}, I) \\ \text{form } \bar{\underline{Y}} &= C^{-1} \underline{Y} \quad \text{note } C^{-1} \underline{N} \sim \mathcal{N}(\underline{0}, I) \end{aligned}$$

Cholesky decomposition offers a **causal whitening filter**.

Note that these decompositions do not offer us anything by way of **performance**. They do offer implementation strategies.

5. Signal Selection

What are the optimal choices for \underline{s}_i ?

Optimization criteria

$$\begin{aligned} \max d^2 &= (\underline{s}_1 - \underline{s}_0)^T \Sigma^{-1} (\underline{s}_1 - \underline{s}_0) \\ \text{subject to } \|\underline{s}_i\|^2 &\leq P \\ \max' \text{ing } d^2 \rightarrow \underline{s}_1 - \underline{s}_0 &= \alpha \underline{v}_{\min} \\ \text{where } \underline{v}_{\min} &= \text{eigenvector of smallest eigenvalue, } \lambda_{\min} \quad \text{and } \alpha = \text{constant} \\ \text{power constraint } \rightarrow \|\underline{s}_i\|^2 &= P \quad \text{and } \underline{s}_1 = -\underline{s}_0 \end{aligned}$$

final solution

$$\begin{aligned} \underline{s}_1 &= \sqrt{P} \underline{v}_{\min} \\ d^2 &= \frac{4P}{\lambda_{\min}} \end{aligned}$$

6. Detection of Signals with Random Parameters

This is simply a composite testing problem:

$$\begin{aligned} H_0 &: \underline{Y} = \underline{N} \\ H_1 &: \underline{Y} = \underline{N} + \underline{s}(\theta) \\ \text{where } \theta &\sim p_{\Theta}(\theta) \end{aligned}$$

Consider the specific example of non-coherent detection of a modulated sinusoidal carrier. The relevant points (see hand-out for a more complete description) are:

- $s_k(\theta) = a_k \sin((k-1)\omega_c T_s + \theta)$ $k = 1, \dots, n$
- $\Theta \sim U[0, 2\pi]$ random phase
- use trigonometric identities,

$$\begin{aligned} \sin(a+b) &= \cos a \sin b + \sin a \cos b \\ \sin^2 a &= \frac{1}{2} - \frac{1}{2} \cos 2a \end{aligned}$$

- define new variables,

$$\begin{aligned} y_c &\doteq \sum_{k=1}^n y_k a_k \cos((k-1)\omega_c T_s) \\ y_s &\doteq \sum_{k=1}^n y_k a_k \sin((k-1)\omega_c T_s) \\ \bar{a}^2 &= \frac{1}{n} \sum_{k=1}^n a_k^2 \\ r &= \sqrt{y_c^2 + y_s^2} \end{aligned}$$

- likelihood ratio reduces to

$$\begin{aligned} L(\underline{y}) &= \exp\left\{-\frac{n\bar{a}^2}{4\sigma^2}\right\} I_0\left(\frac{r}{\sigma^2}\right) \\ I_0 &= \text{modified Bessel function, monotonically increasing in argument} \end{aligned}$$

- performance determined by statistics of Y_c, Y_s ,

$$\begin{aligned} \begin{bmatrix} Y_c | H_i \\ Y_s | H_i \end{bmatrix} &\sim \mathcal{N}\left(\begin{bmatrix} \mu_{c,i} \\ \mu_{s,i} \end{bmatrix}, \begin{bmatrix} \frac{n\bar{a}^2\sigma^2}{2} & 0 \\ 0 & \frac{n\bar{a}^2\sigma^2}{2} \end{bmatrix}\right) \\ \mu_{c,0} = \mu_{s,0} &= 0 \\ \mu_{c,1} &= \frac{n\bar{a}^2}{2} \cos \theta \\ \mu_{s,1} &= \frac{n\bar{a}^2}{2} \sin \theta \end{aligned}$$

- test is compare r to threshold $\tau' = \sigma^2 I_0^{-1}\left(e^{\frac{n\bar{a}^2}{4\sigma^2}}\right)$.

$$P_F = \exp\left(-\frac{\tau'^2}{n\bar{a}^2\sigma^2}\right)$$

Note: detector is an **envelope detector**.

7. Detection of Stochastic Signals

(a) Most general, Gaussian problem:

$$\begin{aligned}
 H_0 & : \underline{Y} \sim \mathcal{N}(\underline{\mu}_0, \Sigma_0) \\
 H_1 & : \underline{Y} \sim \mathcal{N}(\underline{\mu}_1, \Sigma_1) \\
 \rightarrow L(\underline{y}) & = \underbrace{\frac{1}{2} \underline{y}^T [\Sigma_0^{-1} - \Sigma_1^{-1}] \underline{y}}_{\text{quadratic part}} + \underbrace{\left[\underline{\mu}_1^T \Sigma_1^{-1} - \underline{\mu}_0^T \Sigma_0^{-1} \right] \underline{y} + C}_{\text{linear part}}
 \end{aligned}$$

If

- $\Sigma_0 = \Sigma_1 = \Sigma$, quadratic part is zero and we have the Gaussian location testing problem.
- $\underline{\mu}_0 = \underline{\mu}_1$, then consider *wolog* $\underline{\mu}_0 = \underline{\mu}_1 = \underline{0}$ and detector statistic is strictly quadratic since C can be absorbed into threshold.

(b) Consider,

$$\begin{aligned}
 H_0 & : \underline{Y} = \underline{N} \\
 H_1 & : \underline{Y} = \underline{N} + \underline{S} \\
 \underline{N} & \sim \mathcal{N}(0, \sigma^2 I) \quad \underline{S} \sim \mathcal{N}(0, \Sigma_s) \\
 \text{test statistic is } T(\underline{y}) & = \underline{y}^T Q \underline{y} \\
 Q & = \sigma^{-2} \Sigma_s (\sigma^2 I + \Sigma_s)^{-1}
 \end{aligned}$$

Note: this is an **energy detector**.

(c) Relationship between Independent and Dependent Signal Cases

$$\begin{aligned}
 H_0 & : \underline{Y} = \underline{N} \\
 H_1 & : \underline{Y} = \underline{N} + \underline{S} \\
 \underline{N} & \sim \mathcal{N}(0, \sigma^2 I) \quad \underline{S} \sim \mathcal{N}(\underline{\mu}, \Sigma_s) \\
 \text{let } \hat{S}_k & \doteq \mathbf{E}_1 \{Y_k | Y_1 = y_1, \dots, Y_{k-1} = y_{k-1}\} \\
 \text{and } \hat{\sigma}_{S_k}^2 & \doteq \mathbf{Var}_1 \{S_k | Y_1 = y_1, \dots, Y_{k-1} = y_{k-1}\} \\
 \text{then } \hat{\sigma}_{S_k}^2 + \sigma^2 & = \mathbf{Var}_1 \{Y_k | Y_1 = y_1, \dots, Y_{k-1} = y_{k-1}\} \\
 \log L(\underline{y}) & = \frac{1}{2} \sum_{k=1}^n \frac{y_k^2}{\sigma^2} - \frac{1}{2} \sum_{k=1}^n \frac{(y_k - \hat{S}_k)^2}{\hat{\sigma}_{S_k}^2 + \sigma^2} + \frac{1}{2} \sum_{k=1}^n \log \frac{\sigma^2}{\hat{\sigma}_{S_k}^2 + \sigma^2}
 \end{aligned}$$